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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/769,583	GOLASKY ET AL.	
Examiner	Art Unit	
Dieu-Minh Le	2114	

SEARCHED			
Class	Subclass	Date	Examiner
714	4	12/12/2006	DML İ
	43		
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714	56	12/12/2006	DML

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST search all files updated.	12/12/2006	DML
Inventor name search.	12/12/2006	DML
NPL [IEEE & ACM] search.	12/12/2006	DML